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Band Tailing and Deep Defect States in
CH₃NH₃Pb(I₁₋ₓBrₓ)₃ Perovskites as Revealed by
Sub-Bandgap Photocurrent

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ABSTRACT Organometal halide perovskite semiconductors have emerged as promising candidates for optoelectronic applications because of the outstanding charge carrier transport properties, achieved with low temperature synthesis. Here, we present highly sensitive sub-bandgap external quantum efficiency (EQE) measurements of Au/spiro-OMeTAD/CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$/TiO$_2$/FTO/glass photovoltaic devices. The room temperature spectra show exponential band tails with a sharp onset characterized by low Urbach energies ($E_u$) over the full halide composition space. The Urbach energies are 15 - 23 meV, lower than for most semiconductors with similar bandgaps (especially with $E_g > 1.9$ eV). Intentional aging of CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ for up to 2300 hours, reveals no change in $E_u$, despite the appearance of PbI$_2$ phase due to decomposition, and confirms a high degree of crystal ordering. Moreover, sub-bandgap EQE measurements reveal an extended band of sub-bandgap electronic states that can be fit with one or two point defects for pure CH$_3$NH$_3$PbI$_3$ or mixed CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ compositions, respectively. The study provides experimental evidence of defect states close to midgap that could impact photocarrier recombination and energy conversion efficiency in higher bandgap CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ alloys.
Organometal halide perovskites, with the general formula ABX$_3$, have generated enormous interest over the last 7 years as their solar cell power conversion efficiencies have increased from 3.8% in 2009$^1$ to the current world record of 22.1%$^2$. Much of this progress has been realized by composition engineering, at the A site with cations$^3$ including CH(NH$_2$)$_2^+$, CH$_3$NH$_3^+$, and Cs$^+$, at the B site with Pb$^{2+}$ and Sn$^{2+}$ cations$^4$, and at the X site with I$_A$, Br$_A$, and Cl$_A$ anions$^5,6$. These changes have allowed researchers to increase photovoltaic power conversion efficiencies and chemical stabilities, as well as engineer the band gap ($E_g$) for use in high efficiency tandem photovoltaic devices.

Despite the intense interest in composition engineering, the effects of alloying on structural disorder and the densities of states (DOS), particularly within the bandgap, are not well documented. Their characterization is of central importance to identifying factors that contribute to efficiency loss and instability for a number of reasons. First, defects cause non-radiative recombination and modify the band alignment$^7$, second, there is a growing consensus that current-voltage hysteresis and photocurrent transients in organometal perovskite solar cells are due to defect states and related mobile ionic species.$^7,8$ Third, alloying might be expected to increase disorder in a crystal as the variety of possible defect states is increased. Importantly, the optical band edge, characterized by the Urbach energy ($E_u$)$^9$, can be broadened by disorder in the crystal lattice (or by impurities). Low Urbach energies are highly desirable for any semiconductor used in optoelectronic devices. Finally, the evolution of defect states and structural disorder upon aging could play a role in cell degradation.

Probing the role of defects and disorder on optoelectronic properties requires sensitive spectroscopic probes. Defect transitions typically have much longer absorption lengths than
interband transitions therefore requiring the analysis of optical absorption over several orders of magnitude below that at $E_g$. To this end, photothermal deflection spectroscopy (PDS)$^{10,11}$ and Fourier transform photocurrent spectroscopy (FTPS)$^{10}$ have been performed on isolated thin films, and sub-bandgap external quantum efficiency (EQE), transient photocapacitance, and transient photocurrent measurements have been applied to full photovoltaic devices.$^{12,13}$

For CH$_3$NH$_3$PbI$_3$ films, previous PDS and FTPS measurements have shown a purely exponential absorptance behavior with steep slopes that correspond to low values of $E_u$ ($\sim$15 meV) and without the signatures of deep states within the band gap for up to four orders of magnitude of response below $E_g$. $^{10}$ Similarly low values of $E_u$ have been observed for CH$_3$NH$_3$PbBr$_3$ films by PDS ($\sim$25 meV)$^{11}$ and devices by photocurrent spectroscopy ($\sim$14 meV)$^{14}$. Values on mixed bromide/iodide alloys CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ have been more varied. Sadhanala et al. observed higher values of $E_u$ at intermediate $x$ with a peak of 90 meV for $x = 0.8$. $^{11}$ In contrast, Hoke et al. observed low values of $E_u = 12$ - 17 meV over nearly the full range of $x$, with an outlier at $x = 0.5$. $^{14}$

Although the methods described above have been successful at characterizing $E_u$ in CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$) materials and solar cells, the signatures of electronically-active defect states residing deep in the gap are rarely observed. In this regard, highly sensitive sub-bandgap EQE is a particularly powerful approach because it is capable of probing ultra-low photocurrents due to sub-bandgap absorption that can be several orders of magnitude weaker than absorption at $E_g$. High sensitivity is enabled by using a high throughput monochromator, a low-noise current pre-amplifier, and careful filtering of above bandgap stray light, allowing investigation of the sub-bandgap DOS (see Supporting Information for experimental details). Indeed, this method has
recently been applied to CH$_3$NH$_3$PbI$_3$ solar cells to reveal a defect band at 1.34 eV with varying density that was linked to photovoltaic characteristics.$^{12}$

Here, we present sub-bandgap EQE measurements of Au/spiro-OMeTAD/CH$_3$NH$_3$Pb(I$_x$Br$_{1-x}$)$_3$/TiO$_2$/FTO/glass photovoltaic devices at room temperature and extending over the full halide composition space ($0 \leq x \leq 1$). In addition, we assess the impact of long-term aging of devices under atmospheric conditions, as monitored via formation of PbI$_2$, on photoluminescence quantum yields and Urbach energies. Samples were aged for up to 2300 hours in a typical laboratory environment with a temperature of $22\pm 1$ °C and a relative humidity of $50\pm 7\%$. For all compositions, we find Urbach energies in the range of 15 - 23 meV that remain approximately constant throughout the experiment. Moreover, we find direct evidence of sub-bandgap electronic states within the perovskite light absorbers. For pure CH$_3$NH$_3$PbI$_3$ a single, relatively shallow state is observed. With increasing Br-content, this state moves closer to mid-gap while another shallow defect is revealed. If the densities of the defect state nearest mid-gap cannot be controlled, then they will likely enhance Shockley-Read-Hall recombination in higher bandgap perovskites and potentially limit device performance. Our results provide important insight into the defect characteristics of the explored perovskite compositions, with implications for understanding disorder- and defect-induced performance limits.
Figure 1. a) The change in the lattice parameter, as evaluated by the (110) X-ray diffraction peak angle, is plotted versus the halide composition, $x$, determined by EDX measurements. The methylammonium lead halide (CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$) perovskite films were prepared by the vapor-assisted solution process (schematic inset). The upper x-axis provides the bandgap corresponding to composition, calculated according to Ref. 15. b) False colored cross-sectional scanning electron microscopy image of a typical planar Au/spiro-OMeTAD/CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$/TiO$_2$/FTO photovoltaic device fabricated for this study.

CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ films on FTO/TiO$_2$ substrates were synthesized by a two-step, low-pressure, vapor-assisted, solution process (LP-VASP)$^{15,16}$ that yields high material uniformity and quality, with previously reported solar cell power conversion efficiencies of up to 19%$^{17}$. In brief, the process starts with spin-coating and drying of the PbI$_2$/PbBr$_2$ precursor on the substrate in a N$_2$ atmosphere for 15 minutes at 110 °C and is followed by annealing in CH$_3$NH$_3$I and CH$_3$NH$_3$Br vapor for two hours at 120 °C (schematic inset Figure 1a; details on device
processing can be found in the Supporting Information and Ref. 17). This process allows access to the full halide composition space and results in the expected decrease of lattice parameter with increasing Br content, as evaluated by the (110) X-ray diffraction peak angle. In Figure 1a, the (110) peak angle is plotted versus the halide composition of the film, as measured by energy-dispersive X-ray spectroscopy (7 kV, FEI Quanta FEG 250), and is approximately linear over this small range of angles. The halide composition, $x$, in $\text{CH}_3\text{NH}_3\text{Pb}(\text{I}_{1-x}\text{Br}_x)_3$ was related to the optical bandgap as described by the empirical equation $E_g(x) = 1.598 + 0.36x + 0.34x^2$ and is displayed as the upper $x$-axis in Figure 1a.\textsuperscript{15} As mentioned above, sub-bandgap EQE measurements were performed on photovoltaic devices. We fabricated the full stack of Au/spiro-OMeTAD/$\text{CH}_3\text{NH}_3\text{Pb}(\text{I}_{1-x}\text{Br}_x)_3$/TiO$_2$/FTO/glass with a planar device architecture as illustrated in the cross-sectional scanning electron microscopy image in Figure 1b.

The sub-bandgap EQE was measured using long-pass filters to limit above bandgap stray light from a scanning monochromator to one part in $10^7$ throughout most of the spectral range (more experimental details can be found in the Supporting Information and in Ref. 12). Given that light-induced halide segregation has been reported to create I- and Br-rich domains\textsuperscript{14,18}, it is important to note that the monochromatic light intensity used during EQE measurements was $< 0.04 \text{ mW/cm}^2$ above the bandgap of all samples examined. The light intensity varied over the spectral measurement and was below $0.4 \text{ mW/cm}^2$ at $0.8 \text{ eV}$, $0.04 \text{ mW/cm}^2$ at $1.6 \text{ eV}$, and $0.01 \text{ mW/cm}^2$ at $2.3 \text{ eV}$. This is much lower than the $10 - 100 \text{ mW/cm}^2$ used in the studies in which varying degrees of light-induced halide segregation were observed.\textsuperscript{14,15,18} The proposed mechanisms for halide segregation are predicated on the generation of mobile charges and ions, thus low irradiances may limit halide segregation during the measurement. Furthermore, according to prior work, halide segregation in these alloys is fully reversible within a few
minutes of relaxation in the dark.\textsuperscript{14} Because the EQE measurements reported here are performed at least 5 min after exposure to above bandgap light more intense than that used for the measurement itself and the sub-bandgap portion requires hours of data collection, the role of halide segregation should be limited. Nonetheless, light-induced halide segregation in mixed I/Br samples cannot be fully excluded and may contribute, in parallel to defect responses, to sub-bandgap absorption. However, transitions in the samples with $x = 0$ and 1, and below 1.59 eV cannot be explained by the formation of I-rich domains.

Figure 2. a) Sub-bandgap EQE spectra for $x = 0$, 0.4, and 1 reveal the presence of electronically active defects. Fits to the data are shown as solid grey lines, with the underlying gaussian defect distributions shown as solid blue and magenta lines. b) Internal photoluminescence quantum yield (PLQY) extracted at 1-sun illumination for different CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ compositions. The shaded area illustrates non-radiative recombination losses. c) Summary of Urbach energies extracted from EQE and PL measurements plotted against the bandgap. The investigated
CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ films show consistently low Urbach energies between $15 \leq E_u \leq 23$ meV over the full bandgap range of $1.6 \leq E_g \leq 2.3$ eV.

Representative sub-bandgap EQE spectra of CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ devices (with $x = 0, 0.4, \text{ and } 1$) are shown in Figure 2a together with the underlying gaussian defect distributions plotted as solid blue and magenta lines (more sub-bandgap EQE spectra are illustrated in Figure S1 as well as full EQE spectra on a linear scale in Figure S2, Supporting Information). They reveal photocurrent due to optical transitions in the bandgap that likely involve point defects within the perovskite thin films. Sub-bandgap defect-related transitions in the EQE spectra ($EQE_d$) were fit using a function of the form:

$$EQE_d \propto 1 + \text{erf} \left( \frac{E - E_d}{\sigma_d \sqrt{2}} \right)$$

where $E_d$ is the optical transition energy of the defect, $E$ is the incident photon energy, and $\sigma_d$ is the standard deviation of the underlying Gaussian energy density of states associated with a point defect. This functional form is consistent with absorption due to a transition from a Gaussian defect to the valence or conduction band and has been used to describe sub-bandgap absorption spectra of many semiconductors (more information is given in the Supporting Information)$^{19,20}$. For pure CH$_3$NH$_3$PbI$_3$, the best fit was obtained using a single defect model. However, with increasing Br content, the bandgap opens and a second defect-related transition emerges, requiring the use of a two-defect model to describe the response. All defect positions given in the following are the optical transition energies with respect to a band edge, though the technique does not provide information about the carrier type. The defect position ($E_d$) for the
sample with $x = 0$ was observed at 1.36 ± 0.06 eV. For the sample with $x = 0.4$, the two defects were centered at 1.07 ± 0.06 eV and 1.43 ± 0.05 eV, and for the sample with $x = 1$, they were located at 1.42 ± 0.03 eV and 1.89 ± 0.04 eV, respectively. Since the exceedingly low photocurrents measured in sub-bandgap EQE could be generated in any part of the device, reference measurements were performed on spiro-OMeTAD and TiO$_2$ photoconductors (glass/FTO/spiro-OMeTAD/Au and glass/FTO/TiO$_2$/Ti, respectively) under identical conditions. The spiro-OMeTAD photoconductor showed a weak sub-bandgap response centered at 2.2 eV (see Supporting Information Figure S3), which is higher in energy than any defect response observed from perovskite-containing photovoltaic devices. No sub-bandgap response was observed from TiO$_2$. While the TiO$_2$ photoconductor would be expected to show a band-edge optical response in the ultraviolet, the light source provided insufficient intensity in this spectral range and did not produce any measurable photocurrent. Based on these reference measurements, it is concluded that the sub-bandgap response detected from full photovoltaic device stacks is generated within the CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ absorber layers. While the sub-bandgap EQE response corresponds to transitions from bound to free electronic states that generate a photocurrent, it does not indicate whether the observed transitions are associated with trapped holes that are excited to the valence band or trapped electrons that are excited to the conduction band. Therefore, further research will be required to identify the specific nature of these defects, as well as their energetic positions on an absolute scale relative to each band edge, as a function of composition. Regardless of the exact defect positions, the observed sub-bandgap responses suggest that the higher bandgap alloys tend to form defects closer to mid-gap. For example, the 1.36 eV defect observed in the $x = 0$ sample corresponds to a state that is 220 meV from a band edge, and 570 meV away from the midgap position. In stark contrast, the 1.42 eV transition seen
in the $x = 1$ sample is positioned 880 meV away from a band edge, and only 270 meV from the middle of the bandgap. Defects closer to mid-gap are much more efficient recombination centers, even for the same defect density.

In contrast to our finding, some previous density functional theory (DFT) studies have found that deep defects should have prohibitively high formation energies in organolead iodide perovskites\textsuperscript{21,22}. However, others predict a high density of deep traps under I-rich synthesis conditions due to the formation of I-on-Pb antisite ($I_{Pb}$) defects with a formation energy $< 0.2$ eV\textsuperscript{23}. The 1.36, 1.43 and 1.42 eV transitions observed in the $x = 0, 0.4$ and 1 cells, respectively, are within one standard deviation of each other and are a reasonably close match for the $V_{Pb}$ (1-/2-) transition energy predicted as the dominant defect for $x = 0$\textsuperscript{21}. Furthermore, this matches a previously observed defect in $x = 0$ perovskites grown by another technique and whose density was correlated with steady state performance losses and large J-V hysteresis\textsuperscript{12}. Our findings are most consistent with the $V_{Pb}$ appearing at near the same energy relative to the conduction band across the samples studied. The 1.89 eV transition observed in the $x = 1$ cell is a close match for the $V_{Pb}$ (0/-1) transition, which is predicted to be obscured by the valence band in CH$_3$NH$_3$PbI$_3$\textsuperscript{21}. Previous studies have indicated that alloying CH$_3$NH$_3$PbI$_3$ with Br mostly shifts the energetic position of the valence band\textsuperscript{24,25}, suggesting that such defect states would become optoelectronically active as the bandgap opens. Note that the jump in the data appearing near 1.55 eV (Figure 2a) is an artifact of the measurement, due to the addition of a long pass filter at that energy eliminating the contribution of above-bandgap stray light. The impact of stray light on our EQE spectra is discussed in great detail in the Supporting Information.

Both time-resolved photoluminescence (PL)\textsuperscript{26} and PL quantum yield\textsuperscript{15} measurements corroborate the sub-bandgap EQE detection of deep defects by showing that trap-assisted
recombination is the limiting mechanism at low illumination intensities, which are of relevance to the current work. In particular, the former study explained the monoexponential decay observed at low laser fluence by monomolecular (trap-assisted) recombination and the latter study suggested that trap-assisted recombination limits the PL quantum yield at illumination intensities ≤ 1 sun for 0 ≤ x ≤ 1. Figure 2b summarizes the internal PL quantum yield extracted at 1-sun illumination for different CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ compositions measured on LP-VASP perovskite thin films. Further details on PL quantum yield measurements are reported in the Supporting Information and have been published previously in Ref. 15. A PL quantum yield of 100 % would correspond to radiative recombination as the only recombination mechanism in the studied sample. PL quantum yields below 100 % are indicative of non-radiative recombination losses. Figure 2b indicates significantly lower quantum yield in CH$_3$NH$_3$PbBr$_3$. As we have shown previously in our detailed PLQY analysis of CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ films, CH$_3$NH$_3$PbBr$_3$ seems to be limited by trap-assisted recombination over the full range of pump-powers used (Ref. 15). Though, from PLQY it is not clear if the defect density is higher or if the depopulation of traps is significantly faster for x = 1. The combination of PL quantum yield measurements (which probe inherent film properties) indicating trap-assisted recombination at low illumination intensities in the perovskite films (compare Supporting Information, Figure S4, and Ref. 15), and sub-bandgap EQE data, revealing the presence of deep defect states in the absorber layer (with increasing x) of active devices, suggests that deep defects could play an active role in affecting performance characteristics of optoelectronic devices incorporating CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$.

The Urbach energies extracted from EQE measurements versus bandgap are provided in Figure 2c. Bandgaps were determined from Tauc plots$^{27}$ (further experimental details are described in the Supporting Information), resulting in values in the expected range of 1.58 to 2.3
eV. Here, we also report the Urbach energies of LP-VASP samples grown on glass substrates extracted from PL spectra using the van Roosbroeck-Shockley equation, where the optical emission rate is related to the absorption coefficient. All EQE spectra display sharp absorption edges below $E_g$ that translate into low Urbach energies (15 - 23 meV) and are in excellent agreement with those obtained from PL spectra (13 - 19 meV).

It is interesting to compare Urbach energies of CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ films to a range of technologically important inorganic semiconductors used in photovoltaic and other optoelectronic applications. The Urbach energies obtained in this study from fitting of sub-bandgap EQE data are plotted against their optical bandgaps, together with available literature values, in Figure 3. The bandgap range accessible with CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ is highlighted (1.6 ≤ $E_g$ ≤ 2.3 eV) and clearly shows near constant Urbach energies that are significantly lower than in conventional semiconductors, especially for $E_g > 1.9$ eV. This is remarkable given the polycrystalline nature of the hybrid organic-inorganic perovskite thin films, and the nature of the synthesis process, which does not exceed 120 °C and is performed on non-lattice matched substrates. Furthermore, the available literature data for Urbach energies in CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ yielded significantly higher Urbach energy values than reported here for some of the mixed I/Br compositions (compare blue triangles in Figure 3). Possibly, the synthesis method could play a role in defining disorder, particularly in compositionally complex mixed halide perovskites.
Figure 3. Urbach energies versus bandgap with the range accessible by CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ perovskites highlighted in the shaded region. Urbach energies from CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$ perovskites in this study are shown as red squares and from literature data are shown as blue triangles$^{11,14}$. Also shown are a range of technologically important semiconductors (black dots): CZTSSe (Se-rich Cu$_2$ZnSn(S,Se)$_4$)$^{20}$, Si$^{10}$, CIGS (Cu(In,Ga)Se$_2$)$^{19}$, InP$^{29}$, GaAs$^{30}$, CdTe$^{31}$, CZTS (S-rich Cu$_2$ZnSnS$_4$)$^{20}$, CGS (CuGaSe$_2$)$^{32}$, a-Si$^{13}$, a-SiC:H$^{34}$, Al$_{0.05}$In$_{0.95}$N$^{35}$, In$_x$Ga$_{1-x}$N (In-rich, graded In profile)$^{36}$.

While it is well established that methylammonium lead halide perovskites decompose upon exposure to ambient air$^{37}$, less is known about how this process impacts defects and disorder in the material. As mentioned earlier, the unencapsulated devices in this study were aged in the dark under laboratory conditions for up to 2300 h. Reaction with atmospheric species leaves PbI$_2$ as a primary solid state product. Therefore, X-ray diffraction (XRD) can be used to probe changes of the film in fully assembled devices, with the evolution of the (001) PbI$_2$/(110)
perovskite (PbBr₂/perovskite for \( x = 1 \)) XRD integrated peak area ratio providing a useful metric for tracking decomposition as a function of time after synthesis. As shown in Figure 4a (and Figure S5a, Supporting Information), XRD reveals a general trend of increasing PbI₂ with time for mixed I/Br compositions, while the pure I- and Br-perovskite exhibit very little decomposition during the investigated time interval. In parallel, we recorded the sub-bandgap EQE data on the aged samples and extracted the Urbach energies. Figure 4b displays the evolution of the Urbach energies over time for different CH₃NH₃Pb(I₁₋ₓBrₓ)₃ devices. The data points are connected for better visibility and show approximately constant Urbach energies, in the range of 15 - 23 meV, for over 2300 h of degradation. This result indicates that aging and decomposition do not significantly increase disorder and band-tail states within the material.

**Figure 4.** a) Repeated XRD measurements showing the integrated XRD peak ratio of (001) PbI₂/(110) perovskite (PbBr₂/perovskite for \( x = 1 \)) phase as a function of time for different CH₃NH₃Pb(I₁₋ₓBrₓ)₃ compositions. b) Time evolution of Urbach energies under aging, as extracted from sub-bandgap EQE measurements. (data points in a and b are connected as a guide
for the eye) c) Sub-bandgap EQE spectra taken on the same photovoltaic devices as received (0 h) and after extended aging under laboratory conditions.

Examination of the EQE response further below the bandgap reveals that aging does not increase concentrations of energetically deeper defect states, as shown in Figure 4c. For the case of CH$_3$NH$_3$PbI$_3$-based device, the defect-related response appears to be unaffected by aging for up to 791 h, whereas for CH$_3$NH$_3$Pb(I$_{0.1}$Br$_{0.9}$)$_3$-based device the density of defect states seems to decrease after 706 and 2316 hours of aging, during which time this mixed halide sample partially decomposes, as indicated by the formation of PbI$_2$. This finding is consistent with an observed increase in internal PL quantum yield after several weeks of aging, which implies lower defect-mediated recombination rates at low illumination intensities (Supporting Information S4). This increase of PL efficiency with aging time can be explained by passivation of interface states by formation of PbI$_2$.\textsuperscript{38,39} After longer degradation times, it must be considered that the actual active absorptive volume within the device is reduced due to consumption of the perovskite phase and formation of PbI$_2$, which leads to lower overall light absorption and, thus, lower photocurrent response. It is also important to note that PbI$_2$ precipitation was highly non-uniform over the sample (compare photograph in Figure S5b, Supporting Information) and XRD patterns represent an average over regions much larger than the device area probed by EQE (\textit{i.e.} XRD samples regions with and without the Au contact layers, whereas EQE measurements only sample the device active area under the Au contacts).

In summary, we have presented sub-bandgap EQE measurements on Au/spiro-OMeTAD/CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$/TiO$_2$/FTO/glass photovoltaic devices. All CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$
compositions, with corresponding bandgaps of \(1.6 \leq E_g \leq 2.3\) eV, exhibit low Urbach energies in the range of 15 to 23 meV. These Urbach energies are significantly lower than most conventional inorganic semiconductors with similar bandgaps, especially for \(E_g > 1.9\) eV and are not affected by long-term aging of perovskite-based photovoltaic devices (as indicated by co-presence of \(\text{PbI}_2\)). Moreover, this study reveals the presence of sub-bandgap defect states for all compositions. These states can be fit with one or two point defects for pure \(\text{CH}_3\text{NH}_3\text{PbI}_3\) or mixed \(\text{CH}_3\text{NH}_3\text{Pb}(\text{I}_{1-x}\text{Br}_x)_3\) compositions, respectively. With increasing Br-content, the second state emerges, and the observed defect responses indicate that the higher bandgap alloys are characterized by deep level defects with states close to midgap. The combination of sub-bandgap EQE, which can directly detect midgap states, and PL-based studies, which can identify recombination pathways and probabilities, provides a future path toward assessing the roles of synthesis and processing on efficiency-limiting recombination centers in the material.

ASSOCIATED CONTENT

Supporting Information.

The Supporting Information is available free of charge on the ACS Publications website.

Experimental section describing film formation, device processing, sensitive sub-bandgap EQE – including fitting of the spectra, and PL quantum yield measurements. Sub-bandgap EQE measurements on glass/FTO/spiro-OMeTAD/Au and glass/FTO/TiO\(_2\)/Ti photoconductors. Full EQE spectra on a linear scale. PL quantum yield measurements on a \(\text{CH}_3\text{NH}_3\text{Pb}(\text{I}_{0.9}\text{Br}_{0.1})_3\) film under pump-power dependent illumination as-synthesized and re-measured after aging. XRD measurements over time and photograph of aged sample.
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**Notes**

The authors declare no competing financial interest.

**Author Contributions**

The manuscript was written through contributions of all authors. All authors have given approval to the final version of the manuscript. ¹These authors contributed equally.

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(33) Veen, M. K. van; Schropp, R. E. I. Beneficial Effect of a Low Deposition Temperature of


a) Substrate

\[ \text{PbI}_2 / \text{PbBr}_2 \]

\[ \text{Substrate} \]

\[ x, \text{CH}_3\text{NH}_3\text{Pb}(\text{I}_{1-x}\text{Br}_x)_3 \]

b) Au

Spiro OMeTAD

\[ \text{CH}_3\text{NH}_3\text{Pb}(\text{I}_{1-x}\text{Br}_x)_3 \]

TiO\text{\textsubscript{2}}

FTO

1 \text{ \(\mu\text{m}\)}
(a) The graph shows the EQE (external quantum efficiency) curves for different lead halide perovskite compounds, with the energy gaps (E_g) indicated: CH₃NH₃PbI₃ (E_g = 1.58 eV), CH₃NH₃Pb(IₓBr₁₋ₓ)₃ (E_g = 1.8 eV), and CH₃NH₃PbBr₃ (E_g = 2.3 eV). The curves are labeled with "fit" and "Defect 1" for comparison. The lower panel shows the Urbach energy (meV) as a function of the bandgap energy (eV), with data points indicating sub-bandgap EQE and photoluminescence measurements.

(b) The non-radiative recombination losses are presented as a shaded area, with the graph showing the internal PLOY (%) as a function of the bandgap energy. The data points represent the internal PLOY values, with a logarithmic scale on the y-axis.

(c) The graph illustrates the Urbach energy as a function of the bandgap energy for various sub-bandgap EQE and photoluminescence measurements. The extracted data points are represented by different markers, including squares for sub-bandgap EQE and triangles for photoluminescence.
Urbach Energy (meV)

Bandgap Energy (eV)

- CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$, this study
- Lit. CH$_3$NH$_3$Pb(I$_{1-x}$Br$_x$)$_3$
- Lit. other semiconductor materials

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